

# **FDA38N30 N-Channel UniFET<sup>TM</sup> MOSFET** 300 V, 38 A, 85 mΩ

#### Features

- $R_{DS(on)}$  = 70 m $\Omega$  (Typ.) @  $V_{GS}$  = 10 V,  $I_D$  = 19 A
- Low Gate Charge (Typ. 60 nC)
- Low C<sub>rss</sub> (Typ. 60 pF)
- 100% Avalanche Tested
- ESD Improved Capability
- RoHS Compliant

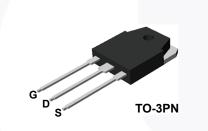
### Applications

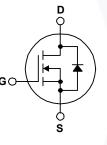
- PDP TV
- Uninterruptible Power Supply
- AC-DC Power Supply

#### May 2014

# Description

UniFET<sup>TM</sup> MOSFET is Fairchild Semiconductor's high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.





## MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

Symbol	Parameter			FDA38N30	Unit	
V <sub>DSS</sub>	Drain to Source Voltage			300	V	
V <sub>GSS</sub>	Gate to Source Voltage			±30	V	
I <sub>D</sub>	Drain Current	- Continuous (T <sub>C</sub> = 25°C)		38	•	
		- Continuous (T <sub>C</sub> = 100 <sup>o</sup> C)		22	— A	
I <sub>DM</sub>	Drain Current	- Pulsed	Pulsed (Note 1)		A	
E <sub>AS</sub>	Single Pulsed Avalanche Energy (			1200	mJ	
I <sub>AR</sub>	Avalanche Current		(Note 1) 38		Α	
E <sub>AR</sub>	Repetitive Avalanche Energ	ду	(Note 1)	31	mJ	
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.5	V/ns	
P <sub>D</sub>	Power Dissipation	(T <sub>C</sub> = 25°C)		312	W	
		- Derate Above 25°C		2.5	W/ºC	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range			-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			300	°C	

# **Thermal Characteristics**

Symbol	Parameter	FDA38N30	Unit		
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max. 0.4				
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient, Max.	40	− °C/W		

FDA38N30
- N-Channel I
UniFET <sup>TM</sup>
MOSFET

Part Number FDA38N30		Top Mark	Package			Та	pe Width	Qua	antity
		FDA38N30	TO-3PN			N/A		30 units	
Electric	al Char	acteristics T <sub>c</sub> = 25°C	unless otherwi	se noted.					
Symbol		Parameter		Conditions		Min.	Тур.	Max	Unit
Off Charac	cteristics				ļ		Į.	ł	
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage		I <sub>D</sub> = 2	$I_D = 250 \ \mu A, V_{GS} = 0 \ V, T_C = 25^{\circ}C$			-	-	V
$\Delta BV_{DSS}$ / $\Delta T_{J}$	Breakdown Voltage Temperature Coefficient		I <sub>D</sub> = 25	$I_D$ = 250 µA, Referenced to 25°C			0.3	-	V/∘C
				V <sub>DS</sub> = 300 V, V <sub>GS</sub> = 0 V		-	-	1	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current		V <sub>DS</sub> =	$V_{DS} = 240 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$			-	10	μA
I <sub>GSS</sub>	Gate-Bod	/ Leakage Current		V <sub>GS</sub> = ±30 V, V <sub>DS</sub> = 0 V			-	±100	nA
On Charac	cteristics								<u> </u>
V <sub>GS(th)</sub>	Gate Threshold Voltage		V <sub>DS</sub> =	V <sub>GS</sub> , I <sub>D</sub> = 250 μA		3.0	-	5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance		V <sub>GS</sub> =	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 19 A		-	0.070	0.085	Ω
9 <sub>FS</sub>	Forward Transconductance		V <sub>DS</sub> =	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 19 A			6.3	-	S
Dynamic O	Characteris	tics							2
C <sub>iss</sub>	Input Cap	acitance		V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz		-	2600	-	pF
C <sub>oss</sub>	Output Ca	pacitance				-	500	-	pF
C <sub>rss</sub>	Reverse T	ransfer Capacitance	I = I K			-	60	-	pF
Q <sub>g(tot)</sub>	Total Gate	Charge at 10V	.,			-	60	-	nC
Q <sub>gs</sub>	Gate to So	ource Gate Charge		$V_{DS} = 240 \text{ V}, \text{ I}_{D} = 38 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4)		-	17	-	nC
Q <sub>gd</sub>	Gate to D	ain "Miller" Charge				-	28	-	nC
	Characteri								
t <sub>d(on)</sub>	1	elay Time				-	53	69	ns
t <sub>r</sub>	Turn-On F	Rise Time		$V_{DD}$ = 150 V, I <sub>D</sub> = 38 A, $R_{G}$ = 25 $\Omega$ , $V_{GS}$ = 10 V (Note 4)		-	110	143	ns
t <sub>d(off)</sub>	Turn-Off D	elay Time	$R_{G} = 2$			-	118	153	ns
t <sub>f</sub>	Turn-Off F	all Time				-	54	70	ns
	rce Diode C	haracteristics	I				1	1	L
Is	Maximum Continuous Drain to Source			rward Current		-	-	38	Α
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current			-	-	150	Α		
V <sub>SD</sub>	Drain to S	ource Diode Forward Volta	ige V <sub>GS</sub> =	e V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 38 A			-	1.4	V
t <sub>rr</sub>	Reverse F	Recovery Time		0 V, I <sub>SD</sub> = 38 A,		-	315	-	ns
Q <sub>rr</sub>	Reverse F	Recovery Charge	dl <sub>F</sub> /dt	dl <sub>F</sub> /dt = 100 A/μs		-	4.0		μC

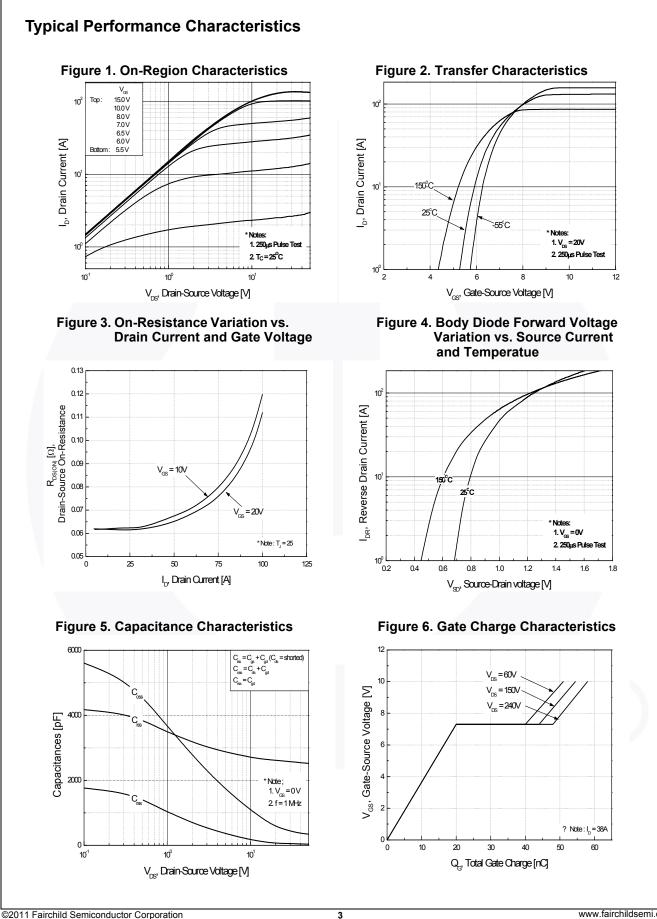
#### Notes:

1. Repetitive rating: pulse-width limited by maximum junction temperature.

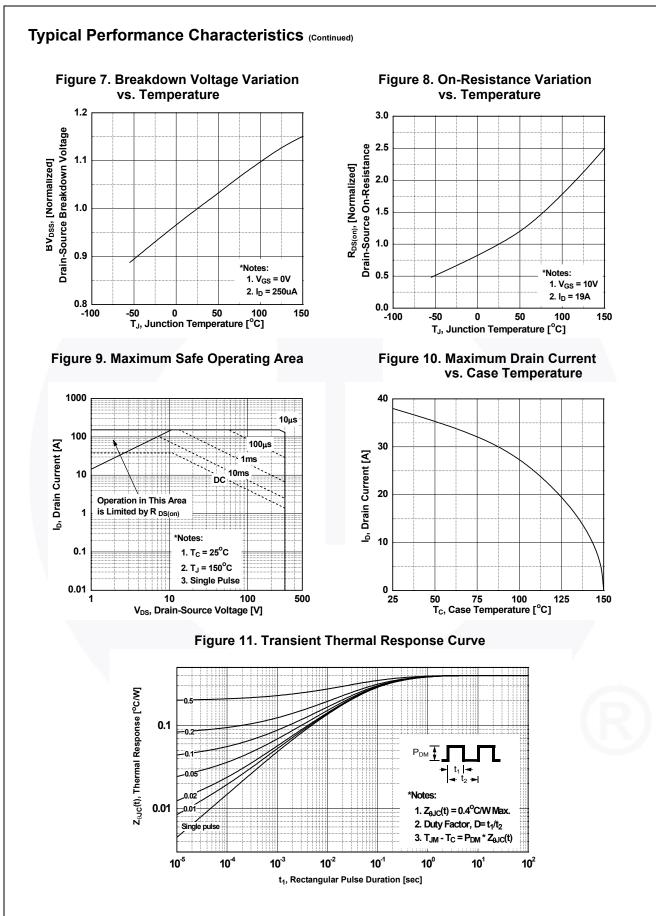
2. L = 1.7 mH, I\_{AS} = 38 A, V\_{DD} = 50 V, R\_G = 25  $\Omega,$  starting T\_J = 25°C.

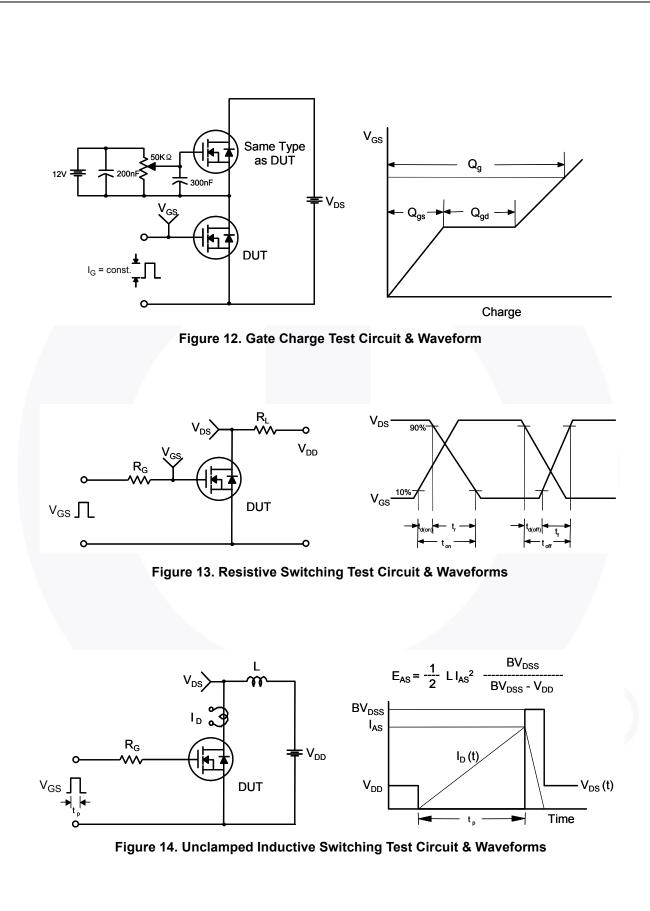
3. I\_{SD}  $\leq$  38 A, di/dt  $\leq$  200 A/µs, V\_{DD}  $\leq$  BV\_{DSS}, starting T\_J = 25°C.

4. Essentially independent of operating temperature typical characteristics.

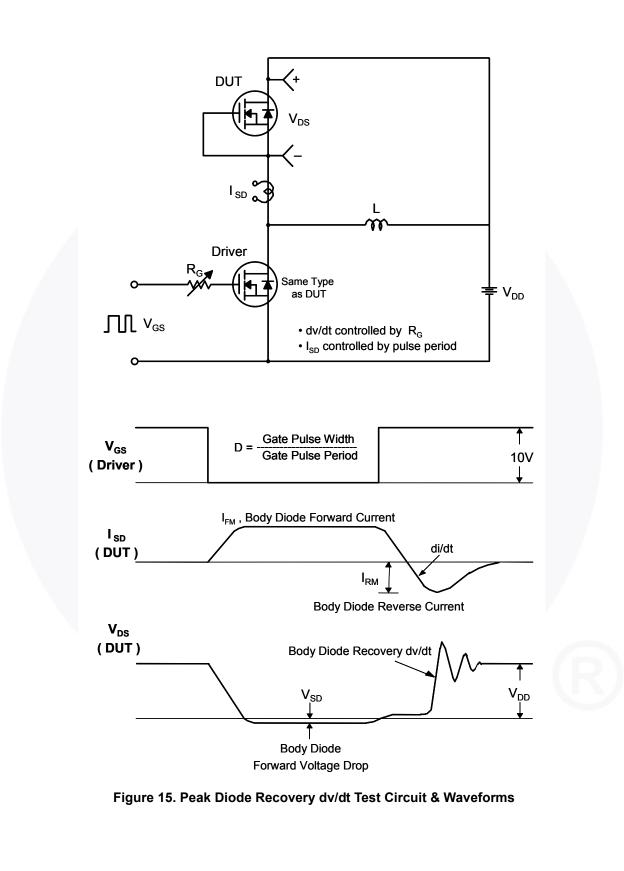


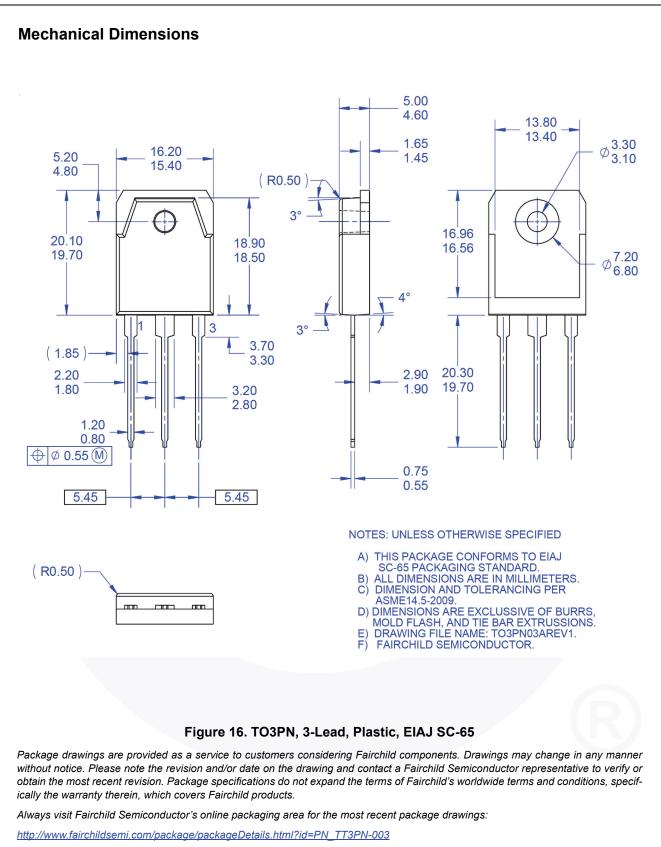
FDA38N30 Rev. C2





FDA38N30 — N-Channel UniFET<sup>TM</sup> MOSFET







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